

M16C/26

Using Timer B for Pulse Period/Width Measurements

1.0 Abstract

The following article introduces and shows how to use Timer B of the M16C/26 (M30262) Flash microcontroller (MCU) for pulse period/width measurements. A sample program written for the MSV30262-SKP, with an accelerometer, shows how to use this Timer B function.

2.0 Introduction

The Renesas M16C/26 is a 16-bit MCU based on the M16C/60 CPU core and has multiple peripheral functions. It has 8 16-bit timers which can be broken into 5 Timer A's and 3 Timer B's. Only Timer B can be used for pulse period/width measurements.

Pulse period/width measurement can be used in applications where in pulse or duty cycles need to be measured. It can be used to measure sensor outputs or verify time periods and duty cycle.

For the demo, pulse outputs from the ADI ADXL210 accelerometer were measured. Using these measurements, acceleration, tilt, or vibration can also be calculated. The demo was written to run on the MSV30262-SKP board with an ADXL210EB evaluation board connected to Timer B0, B1 input pins.

3.0 Timer B

The M16C/26 has three Timer B's, which are all 16-bit timers. The three modes of operations of Timer B are: Timer Mode, Event Counter Mode, and Pulse Period/Pulse Width Measurement Mode. The first two modes are standard timer operations and also exist in the 5 Timer A's. These two modes are discussed in other application notes and are not mentioned in this document. The focus of this document is how to use the third mode, Pulse Period/Pulse Width Measurement Mode. A block diagram of Timer B is shown in Figure 1. Register used in pulse period/width measurement is shown in Figure 2.

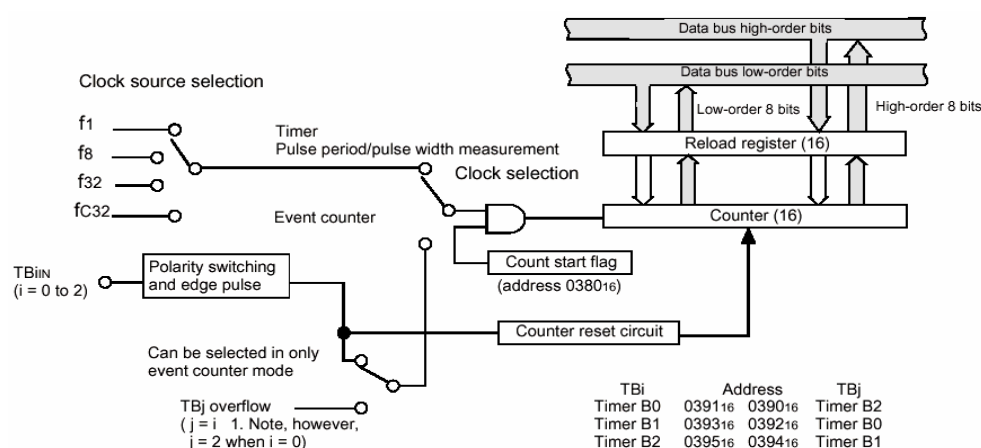


Figure 1 M16C/26 Timer B Block Diagram

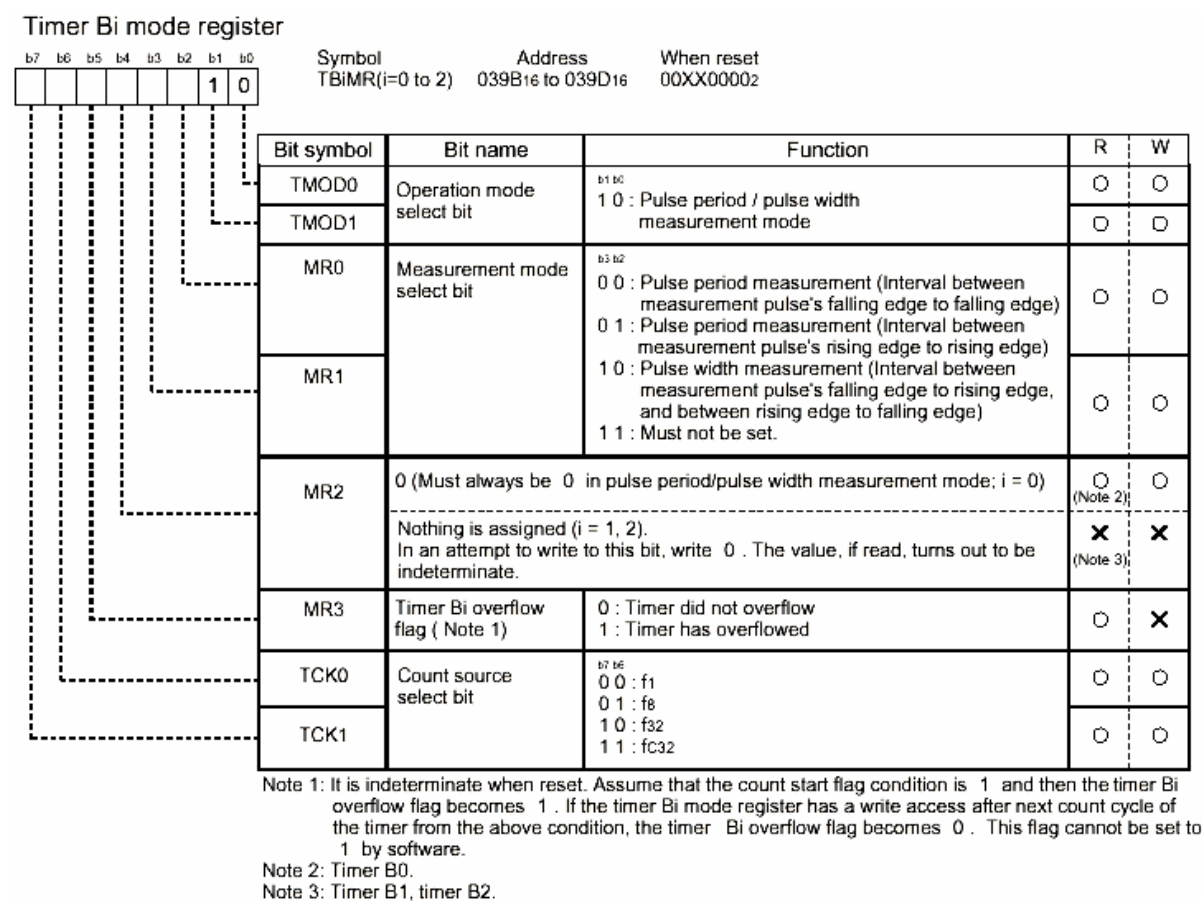


Figure 2 Timer B Mode Register in Pulse Period/Width Measurement Mode

3.1 Measurement Modes

There are three modes in which a pulse can be measured: falling edge-to-falling edge, rising edge-to-rising edge, or rising edge-to-falling edge/falling edge-to-rising edge. The mode can be selected by setting bits 2 and 3 (MR0, MR1) of the Timer B Mode register.

In the demo, two modes are used: rising edge-to-rising edge and rising edge-to-falling edge/falling edge-to-rising edge. The rising edge-to-rising edge mode is used to measure one total cycle (period), t_2 . The rising edge-to-falling edge/falling edge-to-rising edge mode is used to measure the 'On' time, t_1 , of the accelerometer. When measuring the 'On' time of the accelerometer, the port pin where the pulse is connected is polled to determine if the measurement should be used or discarded. The port pin is polled after the measurement is taken (i.e. a Timer B interrupt has occurred). If the port pin is low, then the rising edge-to-falling edge ('On' time) is measured is used. If the port pin is high (i.e. falling edge-to-rising edge), the measurement is discarded.

3.2 Count Source

There are four count sources to choose from: f_1 , f_8 , f_{32} , or fc_{32} . f_1 , f_8 , and f_{32} are clocks derived from the main clock input, X_{in} . f_1 is the frequency of the main clock, f_8 is f_1 divided by 8, and f_{32} is f_1 divided 32. On the other hand, fc_{32} is a clock derived from the subclock input. fc_{32} is the frequency of the subclock, fc , divided by 32. On the MSV30262 Board, f_1 is 20MHz ($f_8=2.5$ MHz, $f_{32}=625$ KHz) and fc is 32.768KHz ($fc_{32}=1024$ Hz).

The importance of the count source is that, it determines the sampling rate of the measurement. For example, if the pulse you need to measure is 1.5ms and you sample it every 1ms, you will miss the width by 0.5ms. If we sample the pulse with every 0.1ms (100us), the pulse measurement will be close to 1.5ms. Figure 3 shows how the sampling clock affects the accuracy of the pulse measurement. As can be seen on the figure, using a faster sampling clock rate makes a more accurate pulse width measurement.

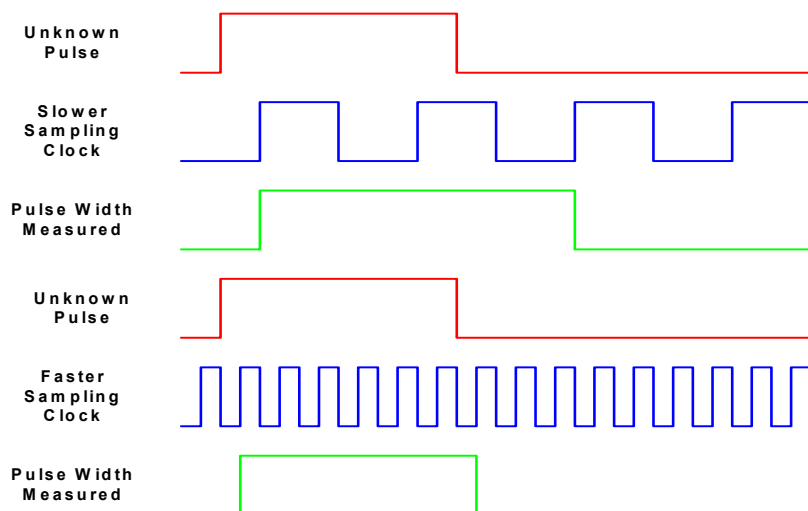


Figure 3 Sampling Clock & Measurement Accuracy

You might be thinking that we should use the fastest sampling clock so we can get the most accurate measurement. We have to remember that the timer must be able to handle the count without overflowing when we used a faster sampling clock. For example, in the demo, the total cycle of the pulse is about 4ms. f1, f8, and f32 can be used as the sampling clock (but not fc32). Timer B is a 16-bit counter, if we used f1, the total count will be $20\text{MHz} \times 4\text{ms}$ which will be equal to 80,000. This count is beyond the 16-bit counter range (65,536). And so, f8 was used for the demo.

```
/* Initialize Timer B0 for t2 measurement */
tb0mr = 0x46;           // f8, measure rising-to-rising edges,
                        // pulse period measurement mode
```

List 1 Timer B Mode Register Initialization for Pulse Period Measurement

```
/* now that we have t2, let's set switch both timers to measure t1, rising-
to-falling edges (or falling-to-rising edges) */
tb0mr = 0x4A;           // f8, measure rising-to-rising edge, PM mode
tb1mr = 0x4A;           // f8, measure rising-to-rising edge, PM mode
```

List 2 Timer B Mode Register Initialization for Pulse Width Measurement

3.3 Interrupts

When taking pulse period/width measurements, interrupts occur after the period or pulse has been measured and is dependent on the mode selected. If using rising edge-to-rising edge mode, the interrupt is generated during the first rising edge of the count source (sampling clock) after the second rising edge of the pulse is detected. If using rising edge-to-falling edge/falling edge-to-rising edge mode, the interrupt is generated on the next rising edge of the count source for every rising or falling edge of the pulse.

4.0 Pulse Period/Width Measurement Demo Program

The demo program was written to run on the MSV30262-SKP board with Analog Device's ADXL210EB Evaluation Board connected to the M16C/26's Timer B input pins. The 'On' time period of the dual axis accelerometer is shown on the LCD. The LCD display is updated every 2 seconds. X-axis PM, in milliseconds (ms), is shown on the upper line while the Y-axis PM is displayed on the lower line of the LCD. Tilting the board sideways, X- or Y-axis, will change the pulse period displayed. Further modifications of the program will allow acceleration, tilt, vibration, or duty cycle measurements.

If you have an MSV30262-SKP, a copy of the source files can be found under the C:\MTOOL\MSV30262-SKP\Sample_Code\PulsMsmt folder after MSV30262-SKP software installation. The program was compiled using the KNC30 Compiler, which also came with the MSV30262-SKP. It can be modified to suit a user application.

5.0 Conclusion

Pulse Period/Width Measurement mode on the M16C/26 MCU allows a simple method of measuring pulse periods or duty cycles. It can be used in applications where time periods, duty cycles, etc., needs to be measured.

6.0 Reference

Renesas Technology Corporation Semiconductor Home Page

<http://www.renesas.com>

E-mail Support

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Data Sheets

- M16C/26 datasheets, M30262eds.pdf

User's Manual

- M16C/20/60 C Language Programming Manual, 6020c.pdf
- M16C/20/60 Software Manual, 6020software.pdf
- Interrupt Handler App Note, M16C26_Interrupt_Handlers_in_C.doc
- MSV30262-SKP Users Manual, Users_Manual_MSV30262.pdf

7.0 Software Code

The pulse period/width measurement demo routines (in pulsmsmt.c) are shown below. The complete project, written in C, can be compiled/linked using the KNC30 compiler and will be provided upon request. Please contact your Renesas representative for details.

```

/*****
*
*   File Name:  pulsmsmt.c
*
*   Content:  Pulse period/width measurement functions for M16C/26 that includes
*             Timer B initialization and interrupt service routines.
*
*   Revision 1.1  2003-02-21
*****/

#include "..\common\sfr262.h" // M16C/26 special function register definitions
#include "..\common\skp26.h" // MSV30262-SKP function definitions
#include "pulsmsmt.h"        // PM function definitions

```

```

/* Timer B0 & B1 irq routines used - vectors modified in sect30_pm.inc */
#pragma INTERRUPT      tb0_int
#pragma INTERRUPT      tb1_int

unsigned int t2;          // t2 period (one total cycle - rising edge to rising edge)
unsigned int t1_tb0, t1_tb1; // t1 pulse ('ON' portion of the total cycle (rising edge to
                             falling edge))

char tb0_flag, tb1_flag = 0; // indicator if Timer B0 or B1 interrupt has occurred

extern char brd_mode;      // Mode:
                           //   INIT      : PWM Initialization
                           //   RUNNING   : App running
                           //   HOLD      : measurements are on-hold
/*****
Name:          init_pm
Parameters:    none
Returns:       none
Description:   PM initialization routine.

                For this demo, two timers are used since the accelerometer is
                dual axis (X & Y). Timer B1 is used for the X-axis and Timer B0
                is used for the Y-axis.
*****/
void init_pm(void){

    /* set timer B0 (P9_0) and B1 (P9_1) GPIO ports to inputs, P93 for self test to output */
    prc2 = 1;          // P9 is write protected - disable protection before writing to P9
    pd9_0 = 0;          // set to timer B0 input
    pd9_1 = 0;          // set to timer B1 input
    pd9_2 = 1;          // unused - set to output
    p9_3 = 0;          // accelerometer self test - off
    pd9_3 = 1;          // set to output - accelerometer self test
    prc2 = 0;          // Write protect P9

    /* Initialize brd_mode to PWM initialization */
    brd_mode = INIT;

    /* measure t2, the width of one cycle, on both timers. t2 is used for calculation */
    get_t2();

    /* set our brd_mode to running */
    brd_mode = RUNNING;
}

/*****
Name:          get_t2
Parameters:    none
Returns:       none
Description:   Gets the width of one cycle, t2, and stores it in memory to be used
                for calculation later.
*****/

```

t2 is measured using timer B0 as it is the same for both X and Y channels (see ADXL210 datasheet for details). Timer B0 is initialized to measure rising edge to rising edge. By doing this, we will be able to measure one cycle (T2), which will be used for later calculation.

f8 is used because it provides high resolution for measuring our pulses (about 5ms cycles). f1 is too high that our 16-bit counter will always time out. f32/fc32 can be used but may not provide enough resolution.

After measuring t2, the timers are reconfigured for measuring t1, i.e. measure rising edge to falling edge.

While the app is running, it is called to compensate for error due to temperature.

```

*****
void get_t2(void){
    char second_t2 = 0;                // indicator for second measurement of t2.
                                        // 1st irq is indeterminate so we have to wait
                                        // for the second one

    /* disable interrupts before we change timer configuration */
    asm("FCLR I");                     // disable interrupts
    tb0ic = 0;                         // disable timer B0 irq
    tb1ic = 0;                         // disable timer B1 irq
    asm("FSET I");                     // enable interrupts

    tb0s = 0;                          // stop timer B0

    /* Initialize Timer B0 for t2 measurement */
    tb0mr = 0x46;                      // f8, measure rising-to-rising edges,
                                        // pulse width measurement mode

    /* enable timer B0 irq only (timer B1 irq remain disabled) for t2 measurement */
    asm("FCLR I");                     // disable interrupts
    tb0ic = 6;                         // enable timer B0 irq only
    asm("FSET I");                     // enable interrupts

    tb0s = 1;                          // start timer B0

    brd_mode = INIT;                   // change brd_mode to INIT for T2 measurement

    /* measure t2 for timer B0 */
    while (second_t2 < 2){              // make two measurements and use the second one
        while (tb0_flag == 0);         // wait for the interrupt and t2_tb0 measurement
        ++second_t2;                   // increment our second measurement indicator
        tb0_flag = 0;                  // initialize flag and wait for second interrupt
    }
    tb0s = 0;                          // stop timer B0

    /* disable interrupts before we change timer configuration */
    asm("FCLR I");                     // disable interrupts
    tb0ic = 0;                         // disable timer B0 irq
    asm("FSET I");                     // enable interrupts

```

```

/* now that we have t2, let's set switch both timers to measure t1, rising-
to-falling edges (or falling-to-rising edges) */
tb0mr = 0x4A;          // f8, measure rising-to-rising edge, PWM mode
tb1mr = 0x4A;          // f8, measure rising-to-rising edge, PWM mode

/* completed PWM initialization, we are ready for our app - enable interrupts*/
asm("FCLR I");         // disable interrupts
tb0ic = 6;             // enable timer B0 irq
tb1ic = 5;             // enable timer B1 irq
asm("FSET I");         // enable interrupts

brd_mode = RUNNING;    // change brd_mode back to RUNNING after T2 measurement

/* start both timers */
tb0s = 1;
tb1s = 1;
}

/*****
Name:          tb0_int
Parameters:    None
Returns:       None
Description:    This is the Timer B0, Y-axis, interrupt routine. During PWM
                initialization, it is used to measure t2, period of one total cycle.
                It is called every rising edge.

                When the app is already running, it is used to measure t1 ('ON'
                portion of the total cycle for the Y-axis). It is called every
                rising or falling edge.

                According to ADXL210 datasheet, 'ON' time t1 is time the pulse is
                in a high/Vcc state. We added a condition (p9_0 == 0) so that only
                measurements between rising-and-falling edges are taken but not
                falling-and-rising edges.

                No need to initialize timer B0 count register, tb0, because it is
                re-initialized after an effective edge.
*****/
void tb0_int(void)
{
    if (brd_mode == RUNNING && p9_0 == 0) // are we in RUNNING brd_mode?
        t1_tb0 = tb0;                    // read current tb0 count and do an average

    if (brd_mode == INIT){                // are we in INIT brd_mode?
        t2 = tb0;                         // yes, read t2 and store it
        tb0_flag = 1;                     // set our timer B0 irq flag
    }
}

```

```
/******
```

Name: tbl_int

Parameters: None

Returns: None

Description: This is the Timer B1, X-axis, interrupt routine.

When the app is already running, it is used to measure t1 ('ON' portion of the total cycle for the X-axis). It is called every rising or falling edge.

According to ADXL210 datasheet, 'ON' time t1 is time the pulse is in a high/Vcc state. We added a condition (p9_1 == 0) so that only measurements between rising-and-falling edges are taken but not falling-and-rising edges.

No need to initialize timer B1 count register, tbl, because it is re-initialized after an effective edge.

```
*****/
```

```
void tbl_int(void)
```

```
{  
    if (brd_mode == RUNNING && p9_1 == 0) // are we in RUNNING brd_mode?  
        t1_tbl = tbl;                     // read current tbl count and do an average  
}
```

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